

74AVC20T245

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

Rev. 9 — 25 June 2024

Product data sheet

1. General description

The 74AVC20T245 is a 20-bit, dual supply transceiver that enables bi-directional voltage level translation. The device can be used as two 10-bit transceivers or as a single 20-bit transceiver. It features four 10-bit input-output ports (1An, 1Bn and 2An, 2Bn), two output enable inputs ($n\overline{OE}$), two direction inputs (nDIR) and dual supplies ($V_{CC(A)}$ and $V_{CC(B)}$). $V_{CC(A)}$ and $V_{CC(B)}$ can be independently supplied at any voltage between 0.8 V and 3.6 V making the device suitable for bi-directional voltage level translation between any of the low voltage nodes: 0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V and 3.3 V. The 1An and 2An ports, $n\overline{OE}$ and nDIR are referenced to $V_{CC(A)}$, the 1Bn and 2Bn ports are referenced to $V_{CC(B)}$. A HIGH on a 1DIR allows transmission from 1An to 1Bn and a LOW on 1DIR allows transmission from 1Bn to 1An. A HIGH on $n\overline{OE}$ causes the outputs to assume a HIGH impedance OFF-state.

The device is fully specified for partial power-down applications using I_{OFF} . The I_{OFF} circuitry disables the output, preventing any damaging backflow current through the device when it is powered down. In suspend mode when either $V_{CC(A)}$ or $V_{CC(B)}$ are at GND level, all output ports will assume a high impedance OFF-state.

2. Features and benefits

- Wide supply voltage range:
 - V_{CC(A)}: 0.8 V to 3.6 V
 - V_{CC(B)}: 0.8 V to 3.6 V
- · Complies with JEDEC standards:
 - JESD8-12 (0.8 V to 1.3 V)
 - JESD8-11 (0.9 V to 1.65 V)
 - JESD8-7 (1.2 V to 1.95 V)
 - JESD8-5 (1.8 V to 2.7 V)
 - JESD8-B (2.7 V to 3.6 V)
- Maximum data rates:
 - 380 Mbit/s (≥ 1.8 V to 3.3 V translation)
 - 260 Mbit/s (≥ 1.1 V to 3.3 V translation)
 - 260 Mbit/s (≥ 1.1 V to 2.5 V translation)
 - 210 Mbit/s (≥ 1.1 V to 1.8 V translation)
 - 120 Mbit/s (≥ 1.1 V to 1.5 V translation)
 - 100 Mbit/s (≥ 1.1 V to 1.2 V translation)
- Suspend mode
- Latch-up performance exceeds 100 mA per JESD 78 Class II
- Inputs accept voltages up to 3.6 V
- I_{OFF} circuitry provides partial Power-down mode operation
- · ESD protection:
 - HBM: ANSI/ESDA/JEDEC JS-001 class 3B exceeds 8000 V
 - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



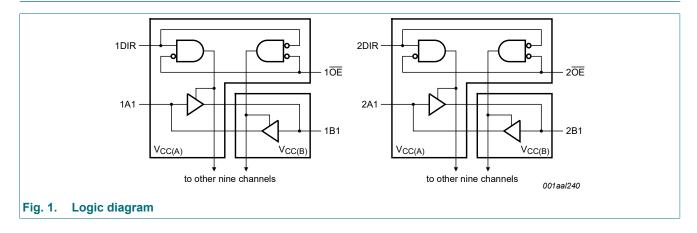
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3. Ordering information

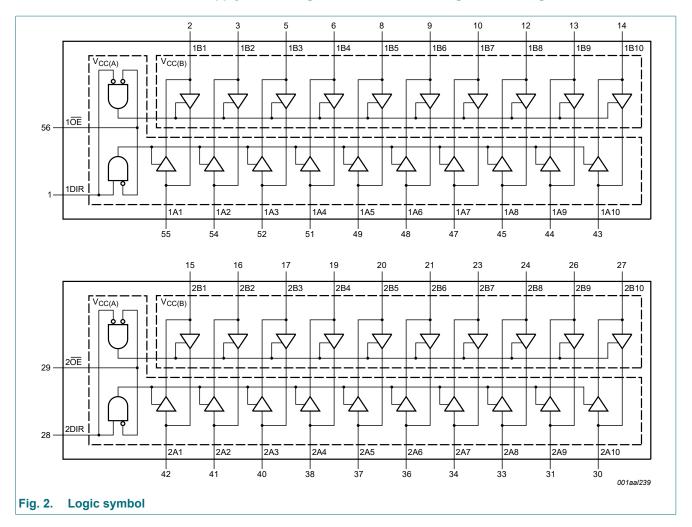
Table 1. Ordering information

Type number	Package	kage							
	Temperature range	Name	Description	Version					
74AVC20T245DGG	-40 °C to +125 °C		plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1					

4. Functional diagram



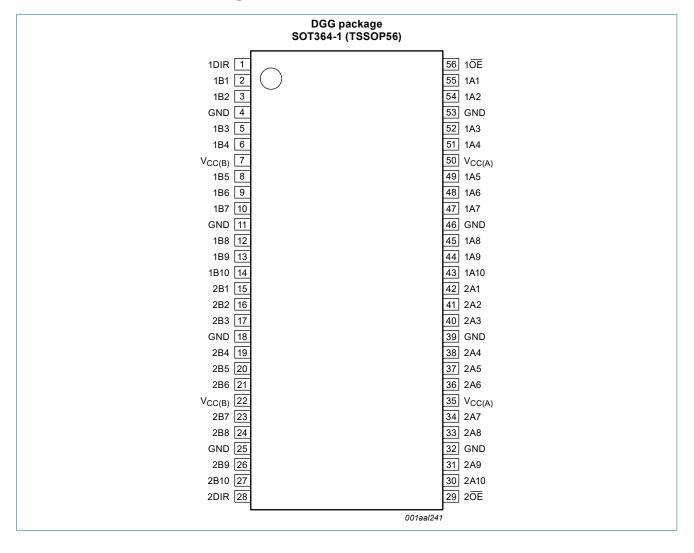
20-bit dual supply translating transceiver with configurable voltage translation; 3-state



20-bit dual supply translating transceiver with configurable voltage translation; 3-state

5. Pinning information

5.1. Pinning



20-bit dual supply translating transceiver with configurable voltage translation; 3-state

5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description		
1DIR, 2DIR	1, 28	direction control		
1B1 to 1B10	2, 3, 5, 6, 8, 9, 10, 12, 13, 14	data input or output		
2B1 to 2B10 15, 16, 17, 19, 20, 21, 23, 24,26, 27		data input or output		
GND[1] 4, 11, 18, 25, 32, 39, 46, 53		ground (0 V)		
V _{CC(B)}	7, 22	supply voltage B (nBn inputs are referenced to V _{CC(B)})		
1 0E , 2 0E	56, 29	output enable input (active LOW)		
1A1 to 1A10	55, 54, 52, 51, 49, 48, 47, 45,44, 43	data input or output		
2A1 to 2A10 42, 41, 40, 38, 37, 36, 34, 33,31, 30		data input or output		
V _{CC(A)}	35, 50	supply voltage A (nAn, nOE and nDIR inputs are referenced to V _{CC(A}		

^[1] All GND pins must be connected to ground (0 V).

6. Functional description

Table 3. Function table

H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

Supply voltage Input			Input/output[1]	Input/output[1]		
V _{CC(A)} , V _{CC(B)}	nOE [2]	nDIR[2]	nAn[2]	nBn[2]		
0.8 V to 3.6 V	L	L	nAn = nBn	input		
0.8 V to 3.6 V	L	Н	input	nBn = nAn		
0.8 V to 3.6 V	Н	X	Z	Z		
GND[1]	Х	X	Z	Z		

If at least one of $V_{CC(A)}$ or $V_{CC(B)}$ is at GND level, the device goes into suspend mode. The nAn, nDIR and nOE input circuit is referenced to $V_{CC(A)}$; The nBn input circuit is referenced to $V_{CC(B)}$.

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC(A)}	supply voltage A			-0.5	+4.6	V
V _{CC(B)}	supply voltage B			-0.5	+4.6	V
I _{IK}	input clamping current	V _I < 0 V		-50	-	mA
VI	input voltage		[1]	-0.5	+4.6	V
I _{OK}	output clamping current	V _O < 0 V		-50	-	mA
V _O	output voltage	Active mode	[1] [2] [3]	-0.5	V _{CCO} + 0.5	V
		Suspend or 3-state mode	[1]	-0.5	+4.6	V
Io	output current	V _O = 0 V to V _{CCO}	[2]	-	±50	mA
I _{CC}	supply current	I _{CC(A)} or I _{CC(B)}		-	100	mA
I_{GND}	ground current			-100	-	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C	[4]	-	500	mW

^[1] The minimum input and minimum output voltage ratings may be exceeded if the input and output clamping current ratings are observed.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC(A)}$	supply voltage A		0.8	3.6	V
V _{CC(B)}	supply voltage B		0.8	3.6	V
VI	input voltage		0	3.6	V
Vo	output voltage	Active mode [1]	0	V _{cco}	V
		Suspend or 3-state mode	0	3.6	V
T _{amb}	ambient temperature		-40	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CCI} = 0.8 V to 3.6 V [2]	-	5	ns/V

^[1] V_{CCO} is the supply voltage associated with the output port.

^[2] V_{CCO} is the supply voltage associated with the output port.

^[3] V_{CCO} + 0.5 V should not exceed 4.6 V.

^[4] For SOT364-1 (TSSOP56) packages: Ptot derates linearly with 12.2 mW/K above 109 °C.

^[2] V_{CCI} is the supply voltage associated with the input port.

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

9. Static characteristics

Table 6. Typical static characteristics at T_{amb} = 25 °C

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).[1] [2]

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		I_{O} = -1.5 mA; $V_{CC(A)} = V_{CC(B)} = 0.8 \text{ V}$	-	0.69	-	V
V_{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}				
		$I_O = 1.5 \text{ mA}; V_{CC(A)} = V_{CC(B)} = 0.8 \text{ V}$	-	0.07	-	V
l _l	input leakage current	nDIR, n \overline{OE} input; V _I = 0 V or 3.6 V; V _{CC(A)} = V _{CC(B)} = 0.8 V to 3.6 V	-	±0.025	±0.25	μΑ
l _{OZ}	OFF-state output current	A or B port; $V_0 = 0 \text{ V or } V_{CCO}$; [3] $V_{CC(A)} = V_{CC(B)} = 3.6 \text{ V}$	-	±0.5	±2.5	μΑ
		suspend mode A port; $V_O = 0 \text{ V or } V_{CCO}$; [3] $V_{CC(A)} = 3.6 \text{ V}$; $V_{CC(B)} = 0 \text{ V}$	-	±0.5	±2.5	μΑ
		suspend mode B port; $V_O = 0 \text{ V or } V_{CCO}$; [3] $V_{CC(A)} = 0 \text{ V}$; $V_{CC(B)} = 3.6 \text{ V}$	-	±0.5	±2.5	μΑ
I _{OFF}	power-off leakage current	A port; V_1 or $V_0 = 0$ V to 3.6 V; $V_{CC(A)} = 0$ V; $V_{CC(B)} = 0.8$ V to 3.6 V	-	±0.1	±1	μΑ
		B port; V_1 or V_0 = 0 V to 3.6 V; $V_{CC(B)}$ = 0 V; $V_{CC(A)}$ = 0.8 V to 3.6 V	-	±0.1	±1	μΑ
Cı	input capacitance	nDIR, n \overline{OE} input; V _I = 0 V or 3.3 V; V _{CC(A)} = V _{CC(B)} = 3.3 V	-	2.0	-	pF
C _{I/O}	input/output capacitance	A and B port; $V_O = 3.3 \text{ V or } 0 \text{ V};$ $V_{CC(A)} = V_{CC(B)} = 3.3 \text{ V}$	-	4.0	_	pF

^[1] V_{CCO} is the supply voltage associated with the output port.

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).[1] [2]

Symbol	Parameter	Conditions	-40 °C to	+85 °C	-40 °C to	-40 °C to +125 °C		
			Min	Max	Min	Max		
V _{IH}	HIGH-level	data input						
	input voltage	V _{CCI} = 0.8 V	0.70V _{CCI}	-	0.70V _{CCI}	-	V	
		V _{CCI} = 1.1 V to 1.95 V	0.65V _{CCI}	-	0.65V _{CCI}	-	V	
		V _{CCI} = 2.3 V to 2.7 V	1.6	-	1.6	-	V	
		V _{CCI} = 3.0 V to 3.6 V	2	-	2	-	V	
		nDIR, nOE input						
		V _{CC(A)} = 0.8 V	0.70V _{CC(A)}	-	0.70V _{CC(A)}	-	V	
		V _{CC(A)} = 1.1 V to 1.95 V	0.65V _{CC(A)}	-	0.65V _{CC(A)}	-	V	
		V _{CC(A)} = 2.3 V to 2.7 V	1.6	-	1.6	-	V	
		V _{CC(A)} = 3.0 V to 3.6 V	2	-	2	-	V	

^[2] V_{CCI} is the supply voltage associated with the data input port.

^[3] For I/O ports, the parameter I_{OZ} includes the input leakage current.

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

Symbol	Parameter	Conditions	-40 °C t	o +85 °C	-40 °C to	Unit		
			Min	Max	Min	Max		
V _{IL}	LOW-level	data input						
	input voltage	V _{CCI} = 0.8 V	-	0.30V _{CCI}	-	0.30V _{CCI}	V	
		V _{CCI} = 1.1 V to 1.95 V	-	0.35V _{CCI}	-	0.35V _{CCI}	V	
		V _{CCI} = 2.3 V to 2.7 V	-	0.7	-	0.7	V	
		V _{CCI} = 3.0 V to 3.6 V	-	0.8	-	0.8	V	
		nDIR, n OE input						
		V _{CC(A)} = 0.8 V	-	0.30V _{CC(A)}	-	0.30V _{CC(A)}	V	
		V _{CC(A)} = 1.1 V to 1.95 V	-	0.35V _{CC(A)}	-	0.35V _{CC(A)}	V	
		V _{CC(A)} = 2.3 V to 2.7 V	-	0.7	-	0.7	V	
		V _{CC(A)} = 3.0 V to 3.6 V	-	0.8	-	0.8	V	
V _{OH}		$V_I = V_{IH}$ or V_{IL}						
	output voltage	$I_O = -100 \mu A;$ $V_{CC(A)} = V_{CC(B)} = 0.8 \text{ V to } 3.6 \text{ V}$	V _{CCO} - 0.1	-	V _{CCO} - 0.1	-	V	
		I_{O} = -3 mA; $V_{CC(A)}$ = $V_{CC(B)}$ = 1.1 V	0.85	-	0.85	-	V	
		I _O = -6 mA; V _{CC(A)} = V _{CC(B)} = 1.4 V		1.05	-	1.05	-	V
		$I_O = -8 \text{ mA};$ $V_{CC(A)} = V_{CC(B)} = 1.65 \text{ V}$		-	1.2	-	V	
		I _O = -9 mA; V _{CC(A)} = V _{CC(B)} = 2.3 V	1.75	-	1.75	-	V	
		I _O = -12 mA; V _{CC(A)} = V _{CC(B)} = 3.0 V	2.3	-	2.3	-	V	
V _{OL}	LOW-level output voltage	V _I = V _{IH} or V _{IL}						
		$I_O = 100 \mu A;$ $V_{CC(A)} = V_{CC(B)} = 0.8 \text{ V to } 3.6 \text{ V}$	-	0.1	-	0.1	V	
		I _O = 3 mA; V _{CC(A)} = V _{CC(B)} = 1.1 V	-	0.25	-	0.25	V	
		I _O = 6 mA; V _{CC(A)} = V _{CC(B)} = 1.4 V	-	0.35	-	0.35	V	
		I _O = 8 mA; V _{CC(A)} = V _{CC(B)} = 1.65 V	-	0.45	-	0.45	V	
		$I_O = 9 \text{ mA}; V_{CC(A)} = V_{CC(B)} = 2.3 \text{ V}$	-	0.55	-	0.55	V	
		I _O = 12 mA; V _{CC(A)} = V _{CC(B)} = 3.0 V	-	0.7	-	0.7	V	
l _l	input leakage current	nDIR, n \overline{OE} input; V _I = 0 V or 3.6 V; V _{CC(A)} = V _{CC(B)} = 0.8 V to 3.6 V	-	±1	-	±5	μΑ	
l _{OZ}	OFF-state output current	A or B port; $V_0 = 0 \text{ V or } V_{CCO}$; [3 $V_{CC(A)} = V_{CC(B)} = 3.6 \text{ V}$] -	±5	-	±30	μΑ	
	output outroint	suspend mode A port; $V_O = 0 \text{ V or } V_{CCO}; V_{CC(A)} = 3.6 \text{ V};$ $V_{CC(B)} = 0 \text{ V}$] -	±5	-	±30	μA	
		suspend mode B port; $V_O = 0 \text{ V or } V_{CC(B)} = 0 \text{ V};$ $V_{CC(B)} = 3.6 \text{ V}$] -	±5	-	±30	μΑ	
l _{OFF}	power-off leakage	A port; V_1 or $V_0 = 0$ V to 3.6 V; $V_{CC(A)} = 0$ V; $V_{CC(B)} = 0.8$ V to 3.6 V	-	±5	-	±30	μΑ	
	current	B port; V _I or V _O = 0 V to 3.6 V; V _{CC(B)} = 0 V; V _{CC(A)} = 0.8 V to 3.6 V	-	±5	-	±30	μΑ	

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

Symbol	Parameter	Conditions	-40 °C t	o +85 °C	-40 °C to +125 °C		Unit
			Min	Max	Min	Max	
I _{CC}	supply current	A port; $V_I = 0 \text{ V or } V_{CCI}$; $I_O = 0 \text{ A}$					
		V _{CC(A)} = 0.8 V to 3.6 V; V _{CC(B)} = 0.8 V to 3.6 V	-	45	-	190	μΑ
		V _{CC(A)} = 1.1 V to 3.6 V; V _{CC(B)} = 1.1 V to 3.6 V	-	35	-	140	μΑ
		V _{CC(A)} = 3.6 V; V _{CC(B)} = 0 V	-	35	-	140	μΑ
		$V_{CC(A)} = 0 \text{ V}; V_{CC(B)} = 3.6 \text{ V}$	-5	-	-20	-	μΑ
		B port; $V_I = 0 \text{ V or } V_{CCI}$; $I_O = 0 \text{ A}$					
		V _{CC(A)} = 0.8 V to 3.6 V; V _{CC(B)} = 0.8 V to 3.6 V	-	45	-	190	μΑ
		V _{CC(A)} = 1.1 V to 3.6 V; V _{CC(B)} = 1.1 V to 3.6 V	-	35	-	140	μΑ
		V _{CC(A)} = 3.6 V; V _{CC(B)} = 0 V	-5	-	-20	-	μA
		V _{CC(A)} = 0 V; V _{CC(B)} = 3.6 V	-	35	-	140	μΑ
		A plus B port ($I_{CC(A)} + I_{CC(B)}$); $I_O = 0 \text{ A}$; $V_I = 0 \text{ V or } V_{CCI}$; $V_{CC(A)} = 0.8 \text{ V to } 3.6 \text{ V}$; $V_{CC(B)} = 0.8 \text{ V to } 3.6 \text{ V}$	-	80	-	270	μА
		A plus B port ($I_{CC(A)} + I_{CC(B)}$); $I_O = 0$ A; $V_I = 0$ V or V_{CCI} ; $V_{CC(A)} = 1.1$ V to 3.6 V; $V_{CC(B)} = 1.1$ V to 3.6 V	-	65	-	220	μА

- [1] V_{CCO} is the supply voltage associated with the output port.
 [2] V_{CCI} is the supply voltage associated with the data input port.
 [3] For I/O ports, the parameter I_{OZ} includes the input leakage current.

Table 8. Typical total supply current $(I_{CC(A)} + I_{CC(B)})$

V _{CC(A)}	V _{CC(B)}				Unit			
	0 V	0.8 V	1.2 V	1.5 V	1.8 V	2.5 V	3.3 V	
0 V	0	0.1	0.1	0.1	0.1	0.1	0.1	μΑ
0.8 V	0.1	0.1	0.1	0.1	0.1	0.3	1.6	μΑ
1.2 V	0.1	0.1	0.1	0.1	0.1	0.1	0.8	μΑ
1.5 V	0.1	0.1	0.1	0.1	0.1	0.1	0.4	μΑ
1.8 V	0.1	0.1	0.1	0.1	0.1	0.1	0.2	μΑ
2.5 V	0.1	0.3	0.1	0.1	0.1	0.1	0.1	μΑ
3.3 V	0.1	1.6	0.8	0.4	0.2	0.1	0.1	μΑ

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

10. Dynamic characteristics

Table 9. Typical power dissipation capacitance at V_{CC(A)} = V_{CC(B)} and T_{amb} = 25 °C

Voltages are referenced to GND (ground = 0 V).[1] [2]

Symbol	Parameter	Conditions			V _{CC(A)} =	= V _{CC(B)}			Unit
			0.8 V	1.2 V	1.5 V	1.8 V	2.5 V	3.3 V	
C _{PD}	power dissipation	A port: (direction A to B); output enabled	0.2	0.2	0.2	0.2	0.3	0.4	pF
		A port: (direction A to B); output disabled	0.2	0.2	0.2	0.2	0.3	0.4	pF
		A port: (direction B to A); output enabled	9.5	9.7	9.8	9.9	10.7	11.9	pF
		A port: (direction B to A); output disabled	0.6	0.6	0.6	0.6	0.7	0.7	pF
		B port: (direction A to B); output enabled	9.5	9.7	9.8	9.9	10.7	11.9	pF
		B port: (direction A to B); output disabled	0.6	0.6	0.6	0.6	0.7	0.7	pF
	B port: (direction B to A); output enabled	0.2	0.2	0.2	0.2	0.3	0.4	pF	
		B port: (direction B to A); output disabled	0.2	0.2	0.2	0.2	0.3	0.4	pF

[1] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:

f_i = input frequency in MHz;

fo = output frequency in MHz;

C_L = load capacitance in pF;

 V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}^2 \times f_0)$ = sum of the outputs.

[2] $f_i = 10 \text{ MHz}$; $V_l = \text{GND to } V_{CC}$; $t_r = t_f = 1 \text{ ns}$; $C_L = 0 \text{ pF}$; $R_L = \infty \Omega$.

Table 10. Typical dynamic characteristics at $V_{CC(A)}$ = 0.8 V and T_{amb} = 25 °C

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 5; for wave forms see Fig. 3 and Fig. 4.[1]

Symbol Parameter Conditions V _{CC(B)}							Unit		
			0.8 V	1.2 V	1.5 V	1.8 V	2.5 V	3.3 V	
t _{pd}	propagation delay	nAn to nBn	14.4	7.0	6.2	6.0	5.9	6.0	ns
		nBn to nAn	14.4	12.4	12.1	11.9	11.8	11.8	ns
t _{dis}	disable time	nOE to nAn	16.2	16.2	16.2	16.2	16.2	16.2	ns
		nOE to nBn	17.6	10.0	9.0	9.1	8.7	9.3	ns
t _{en}	enable time	nOE to nAn	21.9	21.9	21.9	21.9	21.9	21.9	ns
		nOE to nBn	22.2	11.1	9.8	9.4	9.4	9.6	ns

^[1] t_{pd} is the same as t_{PLH} and t_{PHL} ; t_{dis} is the same as t_{PLZ} and t_{PHZ} ; t_{en} is the same as t_{PZL} and t_{PZH} .

Table 11. Typical dynamic characteristics at $V_{CC(B)}$ = 0.8 V and T_{amb} = 25 °C

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 5; for wave forms see Fig. 3 and Fig. 4 [1]

Symbol	Parameter	Conditions	V _{CC(A)}						
			0.8 V	1.2 V	1.5 V	1.8 V	2.5 V	3.3 V	
t _{pd}	propagation delay	nAn to nBn	14.4	12.4	12.1	11.9	11.8	11.8	ns
		nBn to nAn	14.4	7.0	6.2	6.0	5.9	6.0	ns
t _{dis}	disable time	nOE to nAn	16.2	5.9	4.4	4.2	3.1	3.5	ns
		nOE to nBn	17.6	14.2	13.7	13.6	13.3	13.1	ns
t _{en}	enable time	nOE to nAn	21.9	6.4	4.4	3.5	2.6	2.3	ns
		nOE to nBn	22.2	17.7	17.2	17.0	16.8	16.7	ns

^[1] t_{pd} is the same as t_{PLH} and t_{PHL} ; t_{dis} is the same as t_{PLZ} and t_{PHZ} ; t_{en} is the same as t_{PZL} and t_{PZH} .

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

Table 12. Dynamic characteristics for temperature range -40 °C to +85 °C

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 5; for wave forms see Fig. 3 and Fig. 4.[1]

Symbol	Parameter	Conditions	V _{CC(B)}								Unit		
			1.2 V ± 0.1 V		1.5 V ± 0.1 V		1.8 V ± 0.15 V		2.5 V	± 0.2 V	3.3 V ± 0.3 V		
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
V _{CC(A)} =	1.1 V to 1.3 V	1		-		1				1			
t _{pd}	propagation	nAn to nBn	0.5	9.4	0.5	7.1	0.5	6.2	0.5	5.2	0.5	5.1	ns
	delay	nBn to nAn	0.5	9.4	0.5	8.9	0.5	8.7	0.5	8.4	0.5	8.2	ns
t _{dis}	disable time	n OE to nAn	2.0	11.9	2.0	11.9	2.0	11.9	2.0	11.9	2.0	11.9	ns
		n OE to nBn	1.5	12.7	1.5	9.8	1.5	9.6	1.0	8.1	1.0	9.0	ns
t _{en}	enable time	n OE to nAn	1.5	15.3	1.5	15.3	1.5	15.3	1.5	15.3	1.5	15.3	ns
		nOE to nBn	1.0	15.6	1.0	11.5	1.0	10.0	0.5	8.4	0.5	8.0	ns
V _{CC(A)} =	1.4 V to 1.6 V		·	'	'	'	'	1		'	'	1	•
t _{pd}	propagation	nAn to nBn	0.5	8.9	0.5	6.4	0.5	5.4	0.5	4.3	0.5	3.9	ns
	delay	nBn to nAn	0.5	7.1	0.5	6.4	0.5	6.1	0.5	5.8	0.5	5.7	ns
t _{dis}	disable time	n OE to nAn	2.0	9.0	2.0	9.0	2.0	9.0	2.0	9.0	2.0	9.0	ns
		n OE to nBn	1.5	11.7	1.5	9.0	1.5	7.8	1.0	6.4	1.0	6.0	ns
t _{en}	enable time	n OE to nAn	1.5	10.3	1.5	10.3	1.5	10.3	1.5	10.2	1.5	10.2	ns
		n OE to nBn	1.0	14.3	1.0	10.3	1.0	8.4	0.5	6.1	0.5	5.3	ns
V _{CC(A)} =	1.65 V to 1.95	V					'						
t _{pd}	propagation delay	nAn to nBn	0.5	8.7	0.5	6.1	0.5	5.0	0.5	3.9	0.5	3.5	ns
		nBn to nAn	0.5	6.2	0.5	5.4	0.5	5.0	0.5	4.7	0.5	4.6	ns
t _{dis}	disable time	nOE to nAn	2.0	7.4	2.0	7.4	2.0	7.4	2.0	7.4	2.0	7.4	ns
		n OE to nBn	1.5	11.3	1.5	8.7	1.5	7.4	1.0	5.8	1.0	5.6	ns
t _{en}	enable time	nOE to nAn	1.0	8.1	1.0	8.1	1.0	7.9	1.0	7.9	1.0	7.9	ns
		n OE to nBn	0.5	13.8	0.5	10.0	0.5	7.9	0.5	5.7	0.5	4.8	ns
V _{CC(A)} =	2.3 V to 2.7 V												
t _{pd}	propagation	nAn to nBn	0.5	8.4	0.5	5.8	0.5	4.7	0.5	3.5	0.5	3.0	ns
	delay	nBn to nAn	0.5	5.2	0.5	4.3	0.5	3.9	0.5	3.5	0.5	3.4	ns
t _{dis}	disable time	n OE to nAn	1.1	5.2	1.1	5.2	1.1	5.2	1.1	5.2	1.1	5.2	ns
		n OE to nBn	1.2	10.8	1.2	8.2	1.2	6.9	1.0	5.3	1.0	5.2	ns
t _{en}	enable time	n OE to nAn	0.5	5.4	0.5	5.4	0.5	5.3	0.5	5.2	0.5	5.2	ns
		n OE to nBn	0.5	13.3	0.5	9.6	0.5	7.6	0.5	5.3	0.5	4.3	ns
$V_{CC(A)} =$	3.0 V to 3.6 V												
t _{pd}	propagation	nAn to nBn	0.5	8.2	0.5	5.7	0.5	4.6	0.5	3.4	0.5	2.9	ns
	delay	nBn to nAn	0.5	5.1	0.5	3.9	0.5	3.5	0.5	3.0	0.5	2.9	ns
t _{dis}	disable time	n OE to nAn	0.8	5.0	0.8	5.0	0.8	5.0	0.8	5.0	0.8	5.0	ns
		n OE to nBn	1.2	10.5	1.2	8.1	1.2	6.7	1.0	5.1	0.8	5.0	ns
t _{en}	enable time	n OE to nAn	0.5	4.4	0.5	4.4	0.5	4.3	0.5	4.2	0.5	4.1	ns
		n OE to nBn	1.0	13.1	1.0	9.6	0.5	7.5	0.5	5.1	0.5	4.1	ns

^[1] t_{pd} is the same as t_{PLH} and t_{PHL} ; t_{dis} is the same as t_{PLZ} and t_{PHZ} ; t_{en} is the same as t_{PZL} and t_{PZH} .

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

Table 13. Dynamic characteristics for temperature range -40 °C to +125 °C

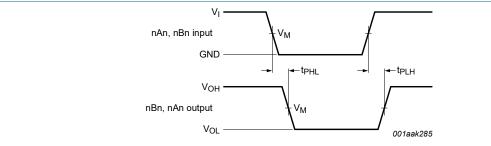
Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 5; for wave forms see Fig. 3 and Fig. 4 [1]

Symbol	Parameter	Conditions	V _{CC(B)}								Unit		
			1.2 V ± 0.1 V		1.5 V ± 0.1 V 1		1.8 V ± 0.15 V		V 2.5 V ± 0.2 V		3.3 V ± 0.3 V		
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	1
V _{CC(A)} =	1.1 V to 1.3 V				<u> </u>				<u> </u>	<u> </u>			
t _{pd}	propagation	nAn to nBn	0.5	10.4	0.5	7.9	0.5	6.9	0.5	5.8	0.5	5.7	ns
	delay	nBn to nAn	0.5	10.4	0.5	9.8	0.5	9.6	0.5	9.3	0.5	9.1	ns
t _{dis}	disable time	n OE to nAn	2.0	13.1	2.0	13.1	2.0	13.1	2.0	13.1	2.0	13.1	ns
		n OE to nBn	1.5	14.0	1.5	10.8	1.5	10.6	1.0	9.0	1.0	9.9	ns
t _{en}	enable time	n OE to nAn	1.5	16.9	1.5	16.9	1.5	16.9	1.5	16.9	1.5	16.9	ns
		nOE to nBn	1.0	17.2	1.0	12.7	1.0	11.0	0.5	9.3	0.5	8.8	ns
V _{CC(A)} =	1.4 V to 1.6 V		ı										
t _{pd}	propagation	nAn to nBn	0.5	9.8	0.5	7.1	0.5	6.0	0.5	4.8	0.5	4.3	ns
	delay	nBn to nAn	0.5	7.9	0.5	7.1	0.5	6.8	0.5	6.4	0.5	6.3	ns
t _{dis}	disable time	nOE to nAn	2.0	9.9	2.0	9.9	2.0	9.9	2.0	9.9	2.0	9.9	ns
		n OE to nBn	1.5	12.9	1.5	9.9	1.5	8.6	1.0	7.1	1.0	6.6	ns
t _{en}	enable time	n OE to nAn	1.5	11.4	1.5	11.4	1.5	11.4	1.5	11.3	1.5	11.3	ns
		n OE to nBn	1.0	15.8	1.0	11.4	1.0	9.3	0.5	6.8	0.5	5.9	ns
V _{CC(A)} =	1.65 V to 1.95	V		'		'	'	1			'	'	
t _{pd}	propagation delay	nAn to nBn	0.5	9.6	0.5	6.8	0.5	5.5	0.5	4.3	0.5	3.9	ns
		nBn to nAn	0.5	6.9	0.5	6.0	0.5	5.5	0.5	5.2	0.5	5.1	ns
t _{dis}	disable time	n OE to nAn	2.0	8.2	2.0	8.2	2.0	8.2	2.0	8.2	2.0	8.2	ns
		n OE to nBn	1.5	12.5	1.5	9.6	1.5	8.2	1.0	6.4	1.0	6.2	ns
t _{en}	enable time	nOE to nAn	1.0	9.0	1.0	9.0	1.0	8.7	1.0	8.7	1.0	8.7	ns
		n OE to nBn	0.5	15.2	0.5	11.0	0.5	8.7	0.5	6.3	0.5	5.3	ns
V _{CC(A)} =	2.3 V to 2.7 V												
t _{pd}	propagation	nAn to nBn	0.5	9.3	0.5	6.4	0.5	5.2	0.5	3.9	0.5	3.3	ns
	delay	nBn to nAn	0.5	5.8	0.5	4.8	0.5	4.3	0.5	3.9	0.5	3.8	ns
t _{dis}	disable time	n OE to nAn	1.1	5.8	1.1	5.8	1.1	5.8	1.1	5.8	1.1	5.8	ns
		n OE to nBn	1.2	11.9	1.2	9.1	1.2	7.6	1.0	5.9	1.0	5.8	ns
t _{en}	enable time	n OE to nAn	0.5	6.0	0.5	6.0	0.5	5.9	0.5	5.8	0.5	5.8	ns
		n OE to nBn	0.5	14.7	0.5	10.6	0.5	8.4	0.5	5.9	0.5	4.8	ns
V _{CC(A)} =	3.0 V to 3.6 V												
t _{pd}	propagation	nAn to nBn	0.5	9.1	0.5	6.3	0.5	5.1	0.5	3.8	0.5	3.2	ns
	delay	nBn to nAn	0.5	5.7	0.5	4.3	0.5	3.9	0.5	3.3	0.5	3.2	ns
t _{dis}	disable time	n OE to nAn	8.0	5.5	8.0	5.5	0.8	5.5	8.0	5.5	0.8	5.5	ns
		n OE to nBn	1.2	11.6	1.2	9.0	1.2	7.4	1.0	5.7	0.8	5.5	ns
t _{en}	enable time	n OE to nAn	0.5	4.9	0.5	4.9	0.5	4.8	0.5	4.7	0.5	4.6	ns
		n OE to nBn	1.0	14.5	1.0	10.6	0.5	8.3	0.5	5.7	0.5	4.6	ns

 $^{[1] \}quad t_{pd} \text{ is the same as } t_{PLH} \text{ and } t_{PHL}; \ t_{dis} \text{ is the same as } t_{PLZ} \text{ and } t_{PHZ}; \ t_{en} \text{ is the same as } t_{PZL} \text{ and } t_{PZH}.$

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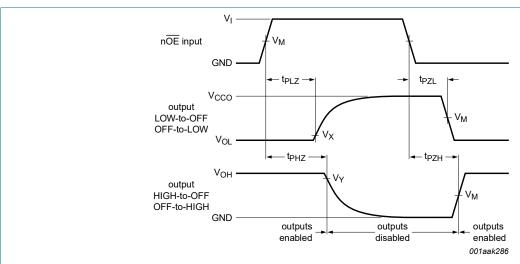
10.1. Waveforms and test circuit



Measurement points are given in Table 14.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig. 3. The data input (nAn, nBn) to output (nBn, nAn) propagation delay times



Measurement points are given in <u>Table 14</u>.

 V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig. 4. Enable and disable times

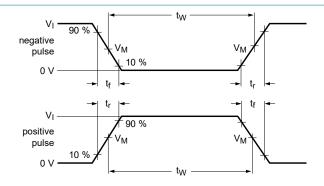
Table 14. Measurement points

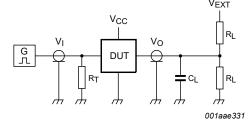
Supply voltage	Input [1]	Output [2]	Output [2]					
V _{CC(A)} , V _{CC(B)}	V _M	V _M	V _X	V _Y				
0.8 V to 1.6 V	0.5V _{CCI}	0.5V _{CCO}	V _{OL} + 0.1 V	V _{OH} - 0.1 V				
1.65 V to 2.7 V	0.5V _{CCI}	0.5V _{CCO}	V _{OL} + 0.15 V	V _{OH} - 0.15 V				
3.0 V to 3.6 V	0.5V _{CCI}	0.5V _{CCO}	V _{OL} + 0.3 V	V _{OH} - 0.3 V				

^[1] V_{CCI} is the supply voltage associated with the data input port.

^[2] V_{CCO} is the supply voltage associated with the output port.

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Test data is given in Table 15.

Definitions test circuit:

R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance.

V_{EXT} = External voltage for measuring switching times.

Fig. 5. Test circuit for measuring switching times

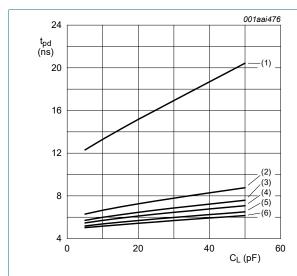
Table 15. Test data

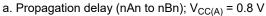
Supply voltage Input		Load		V _{EXT}			
$V_{CC(A)}, V_{CC(B)}$	V _I [1]	Δt/ΔV [2]	CL	R _L	t _{PLH} , t _{PHL}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ} [3]
0.8 V to 1.6 V	V _{CCI}	≤ 1.0 ns/V	15 pF	2 kΩ	open	GND	2V _{CCO}
1.65 V to 2.7 V	V _{CCI}	≤ 1.0 ns/V	15 pF	2 kΩ	open	GND	2V _{CCO}
3.0 V to 3.6 V	V _{CCI}	≤ 1.0 ns/V	15 pF	2 kΩ	open	GND	2V _{CCO}

- [1] V_{CCI} is the supply voltage associated with the data input port.
- [2] dV/dt ≥ 1.0 V/ns
- [3] V_{CCO} is the supply voltage associated with the output port.

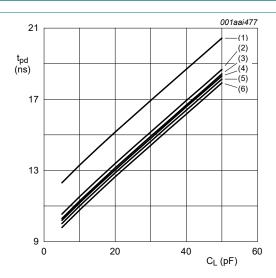
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11. Typical propagation delay characteristics





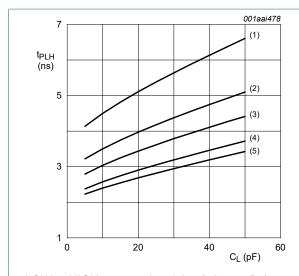
- (1) $V_{CC(B)} = 0.8 \text{ V}$
- (2) $V_{CC(B)} = 1.2 \text{ V}$
- (3) $V_{CC(B)} = 1.5 \text{ V}$
- (4) $V_{CC(B)} = 1.8 \text{ V}$
- (5) $V_{CC(B)} = 2.5 \text{ V}$
- (6) $V_{CC(B)} = 3.3 \text{ V}$



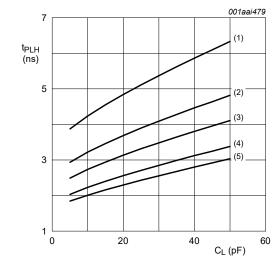
- b. Propagation delay (nAn to nBn); $V_{CC(B)} = 0.8 \text{ V}$
- (1) $V_{CC(A)} = 0.8 \text{ V}$
- (2) $V_{CC(A)} = 1.2 \text{ V}$
- (3) $V_{CC(A)} = 1.5 V$ (4) $V_{CC(A)} = 1.8 V$
- $(5) V_{CC(A)} = 2.5 V$
- (6) $V_{CC(A)} = 3.3 \text{ V}$

Fig. 6. Typical propagation delay versus load capacitance; T_{amb} = 25 °C

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a. LOW to HIGH propagation delay (nAn to nBn); $V_{CC(A)} = 1.2 \text{ V}$

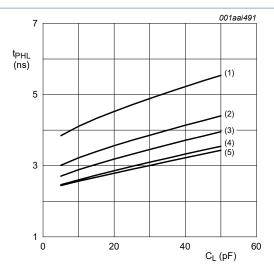


c. LOW to HIGH propagation delay (nAn to nBn);

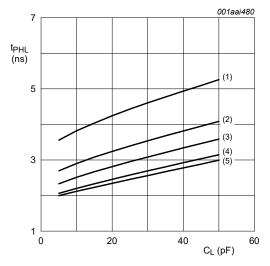
 $V_{CC(A)} = 1.5 V$

(1) $V_{CC(B)} = 1.2 \text{ V}$ (2) $V_{CC(B)} = 1.5 \text{ V}$ (3) $V_{CC(B)} = 1.8 \text{ V}$ (4) $V_{CC(B)} = 2.5 \text{ V}$

(5) $V_{CC(B)} = 3.3 \text{ V}$



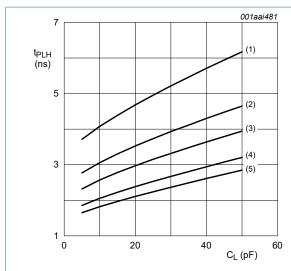
b. HIGH to LOW propagation delay (nAn to nBn); $V_{CC(A)} = 1.2 \text{ V}$



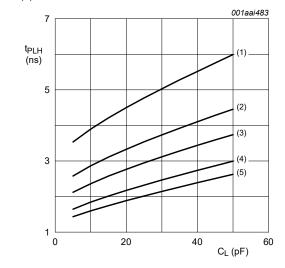
d. HIGH to LOW propagation delay (nAn to nBn); $V_{CC(A)} = 1.5 V$

Fig. 7. Typical propagation delay versus load capacitance; $T_{amb} = 25$ °C

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a. LOW to HIGH propagation delay (nAn to nBn); $V_{CC(A)} = 1.8 \text{ V}$

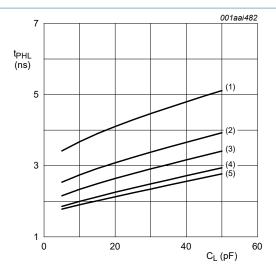


c. LOW to HIGH propagation delay (nAn to nBn);

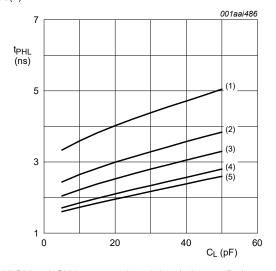
 $V_{CC(A)} = 2.5 \text{ V}$

(1) $V_{CC(B)} = 1.2 \text{ V}$ (2) $V_{CC(B)} = 1.5 \text{ V}$ (3) $V_{CC(B)} = 1.8 \text{ V}$ (4) $V_{CC(B)} = 2.5 \text{ V}$

(5) $V_{CC(B)} = 3.3 \text{ V}$



b. HIGH to LOW propagation delay (nAn to nBn); $V_{CC(A)} = 1.8 \text{ V}$

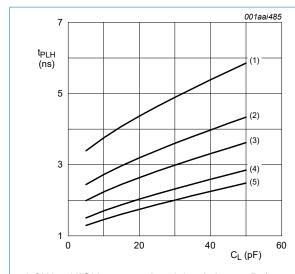


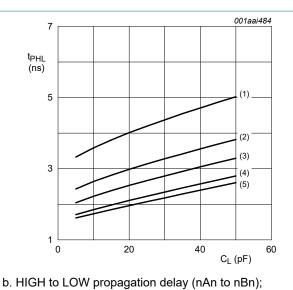
d. HIGH to LOW propagation delay (nAn to nBn); $V_{CC(A)} = 2.5 \text{ V}$

Fig. 8. Typical propagation delay versus load capacitance; $T_{amb} = 25$ °C

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

 $V_{CC(A)} = 3.3 \text{ V}$





a. LOW to HIGH propagation delay (nAn to nBn);

 $V_{CC(A)} = 3.3 \text{ V}$

- (1) $V_{CC(B)} = 1.2 \text{ V}$

- (1) $V_{CC(B)} = 1.2 \text{ V}$ (2) $V_{CC(B)} = 1.5 \text{ V}$ (3) $V_{CC(B)} = 1.8 \text{ V}$ (4) $V_{CC(B)} = 2.5 \text{ V}$ (5) $V_{CC(B)} = 3.3 \text{ V}$

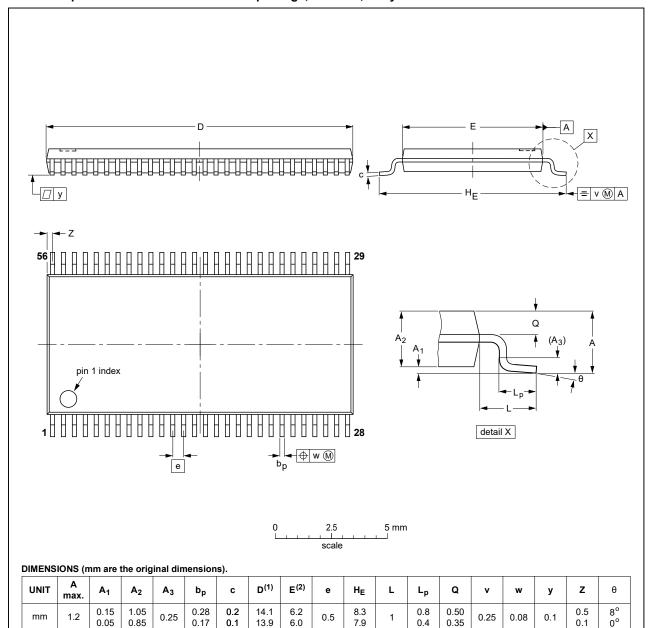
Fig. 9. Typical propagation delay versus load capacitance; T_{amb} = 25 °C

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

12. Package outline

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm

SOT364-1



Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- $2. \ Plastic \ interlead \ protrusions \ of \ 0.25 \ mm \ maximum \ per \ side \ are \ not \ included.$

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT364-1		MO-153				99-12-27 03-02-19	

Fig. 10. Package outline SOT364-1 (TSSOP56)

20-bit dual supply translating transceiver with configurable voltage translation; 3-state

13. Abbreviations

Table 16. Abbreviations

Acronym	Description
ANSI	American National Standards Institute
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
ESDA	ElectroStatic Discharge Association
НВМ	Human Body Model
JEDEC	Joint Electron Device Engineering Council

14. Revision history

Table 17. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74AVC20T245 v.9	20240625	Product data sheet	-	74AVC20T245 v.8
Modifications:		ESD specification update P _{tot} and derating values f	•	
74AVC20T245 v.8	20190114	Product data sheet	-	74AVC20T245 v.7
Modifications:	guidelines of Legal texts	of this data sheet has be of Nexperia. have been adapted to th ers 74AVC20T245DGV a	e new company nar	ne where appropriate.
74AVC20T245 v.7	20120308	Product data sheet	-	74AVC20T245 v.6
Modifications:	For type nu	mber 74AVC20T245BX t	the sot code has cha	anged to SOT1134-2.
74AVC20T245 v.6	20111207	Product data sheet	-	74AVC20T245 v.5
Modifications:	Legal page	s updated.	,	
74AVC20T245 v.5	20110616	Product data sheet	-	74AVC20T245 v.4
74AVC20T245 v.4	20101124	Product data sheet	-	74AVC20T245 v.3
74AVC20T245 v.3	20100622	Product data sheet	-	74AVC20T245 v.2
74AVC20T245 v.2	20100318	Product data sheet	-	74AVC20T245 v.1
7 17 (V OZOTZ TO V.Z	20100010			

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15. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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20-bit dual supply translating transceiver with configurable voltage translation; 3-state

Contents

1. General description	1
2. Features and benefits	1
3. Ordering information	2
4. Functional diagram	2
5. Pinning information	4
5.1. Pinning	4
5.2. Pin description	5
6. Functional description	5
7. Limiting values	
8. Recommended operating conditions	6
9. Static characteristics	
10. Dynamic characteristics	10
10.1. Waveforms and test circuit	13
11. Typical propagation delay characteristics	15
12. Package outline	
13. Abbreviations	
14. Revision history	
15. Legal information	
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